ON Semiconductor®

FGB40T65SPD-F085
650V, 40A Field Stop Trench IGBT

Features
- AEC-Q101 Qualified
- Low Saturation Voltage : $V_{CE(sat)}$ = 2.0 V(Typ.) @ I_C = 40 A
- 100% of the parts are dynamically tested (Note 1)
- Short Circuit Ruggedness > 5 μs @ 25 °C
- Maximum Junction Temperature : T_J = 175 °C
- Fast Switching
- Tight Parameter Distribution
- Positive Temperature Coefficient for Easy Parallel Operation
- Copacked with soft, fast recovery diode
- RoHS Compliant

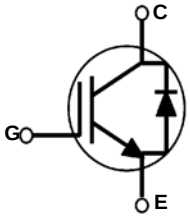
General Description
Using the novel field stop 3rd generation IGBT technology, FGH40T65SPD-F085 offers the optimum performance with both low conduction loss and switching loss for a high efficiency operation in various applications, while provides 50V higher blocking voltage and rugged high current switching reliability. Meanwhile, this part also offers and advantage of outstanding performance in parallel operation.

Applications
- Onboard Charger
- AirCon Compressor
- PTC Heater
- Motor Drivers
- Other automotive power-train and auxiliary applications

COLLECTOR (FLANGE)

TO-263AB/D²-PAK

G C E



Absolute Maximum Ratings

Symbol	Description		Ratings	Units
V_{CES}	Collector to Emitter Voltage		650	V
V_{GES}	Gate to Emitter Voltage		± 20	V
	Transient Gate to Emitter Voltage		± 30	V
I_C	Collector Current	@ T_C = 25 °C	80	A
	Collector Current	@ T_C = 100 °C	40	A
I_{CM}	Pulsed Collector Current	(Note 2)	120	A
I_F	Diode Forward Current	@ T_C = 25 °C	40	A
	Diode Forward Current	@ T_C = 100 °C	20	A
I_{FM}	Pulsed Diode Maximum Forward Current	(Note 2)	120	A
P_D	Maximum Power Dissipation	@ T_C = 25 °C	267	W
	Maximum Power Dissipation	@ T_C = 100 °C	134	W
SCWT	Short Circuit Withstand Time	@ T_C = 25 °C	5	μs
T_J	Operating Junction Temperature		-55 to +175	°C
T_{stg}	Storage Temperature Range		-55 to +175	°C
T_L	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes:
1: V_{CC} = 400 V, V_{GE} = 15 V, I_C = 120 A, R_G = 20 Ω, Inductive Load
2: Repetitive rating: pulse width limited by max. junction temperature

September-2017, Rev. 2

Publication Order Number:
FGB40T65SPD-F085/D

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Qty per Reel
FGB40T65SPD	FGB40T65SPD-F085	TO-263AB/D2-PAK	-	-	800ea

Electrical Characteristics of the IGBT T_C = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
Off Characteristics						
BV_{CES}	Collector to Emitter Breakdown Voltage	V_{GE} = 0V, I_C = 1mA	650	-	-	V
$\frac{\Delta BV_{CES}}{\Delta T_J}$	Temperature Coefficient of Breakdown Voltage	V_{GE} = 0V, I_C = 1mA	-	0.6	-	V/°C
I_{CES}	Collector Cut-Off Current	V_{CE} = V_{CES}, V_{GE} = 0V	-	-	250	μA
I_{GES}	G-E Leakage Current	V_{GE} = V_{GES}, V_{CE} = 0V	-	-	± 400	nA
On Characteristics						
$V_{GE(th)}$	G-E Threshold Voltage	I_C = 40mA, V_{CE} = V_{GE}	4.0	5.8	7.5	V
$V_{CE(sat)}$	Collector to Emitter Saturation Voltage	I_C = 40A, V_{GE} = 15V	-	2.0	2.4	V
		I_C = 40A, V_{GE} = 15V, T_C = 175 °C	-	2.9	-	V
Dynamic Characteristics						
C_{ies}	Input Capacitance	V_{CE} = 30V, V_{GE} = 0V, f = 1MHz	-	1520	-	pF
C_{oes}	Output Capacitance		-	92	-	pF
C_{res}	Reverse Transfer Capacitance		-	15	-	pF
Switching Characteristics						
$T_{d(on)}$	Turn-On Delay Time	V_{CC} = 400V, I_C = 40A, R_G = 6Ω, V_{GE} = 15V, Inductive Load, T_C = 25 °C	-	18	-	ns
T_r	Rise Time		-	26	-	ns
$T_{d(off)}$	Turn-Off Delay Time		-	35	-	ns
T_f	Fall Time		-	10	-	ns
E_{on}	Turn-On Switching Loss		-	0.97	-	mJ
E_{off}	Turn-Off Switching Loss		-	0.28	-	mJ
E_{ts}	Total Switching Loss		-	1.25	-	mJ
$T_{d(on)}$	Turn-On Delay Time	V_{CC} = 400V, I_C = 40A, R_G = 6Ω, V_{GE} = 15V, Inductive Load, T_C = 175 °C	-	14	-	ns
T_r	Rise Time		-	35	-	ns
$T_{d(off)}$	Turn-Off Delay Time		-	38	-	ns
T_f	Fall Time		-	13	-	ns
E_{on}	Turn-On Switching Loss		-	1.61	-	mJ
E_{off}	Turn-Off Switching Loss		-	0.47	-	mJ
E_{ts}	Total Switching Loss		-	2.08	-	mJ
T_{SC}	Short Circuit Withstand Time	V_{CC} = 400V, V_{GE} = 15V, R_G = 10Ω	5	-	-	μs

Electrical Characteristics of the IGBT (Continued)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max	Units
Q_g	Total Gate Charge	V_{CE} = 400V, I_C = 40A, V_{GE} = 15V	-	36	-	nC
Q_{ge}	Gate to Emitter Charge		-	12	-	nC
Q_{gc}	Gate to Collector Charge		-	11	-	nC

Electrical Characteristics of the Diode T_C = 25 °C unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Typ.	Max	Units
V_{FM}	Diode Forward Voltage	I_F = 20A	T_C = 25 °C	-	2.0	2.7	V
			T_C = 175 °C	-	1.8	-	
E_{rec}	Reverse Recovery Energy	I_F = 20A, dI_F/dt = 200A/μs	T_C = 175 °C	-	51	-	μJ
T_{rr}	Diode Reverse Recovery Time		T_C = 25 °C	-	34	-	ns
			T_C = 175 °C	-	206	-	
Q_{rr}	Diode Reverse Recovery Charge		T_C = 25 °C	-	56	-	nC
			T_C = 175 °C	-	731	-	

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$(IGBT)	Thermal Resistance, Junction to Case	-	0.56	°C/W
$R_{\theta JC}$(Diode)	Thermal Resistance, Junction to Case	-	1.71	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	40	°C/W

Typical Performance Characteristics

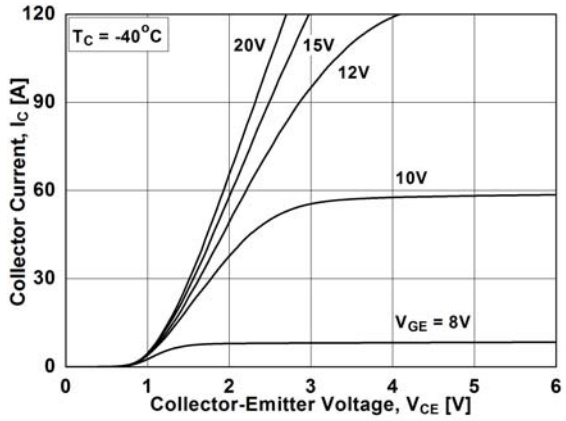


Figure 1. Typical Output Characteristics

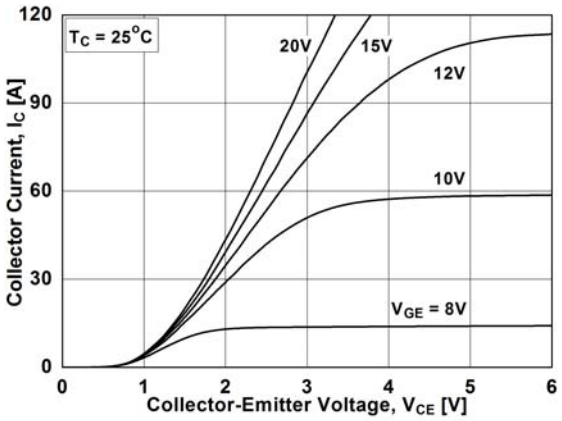


Figure 2. Typical Output Characteristics

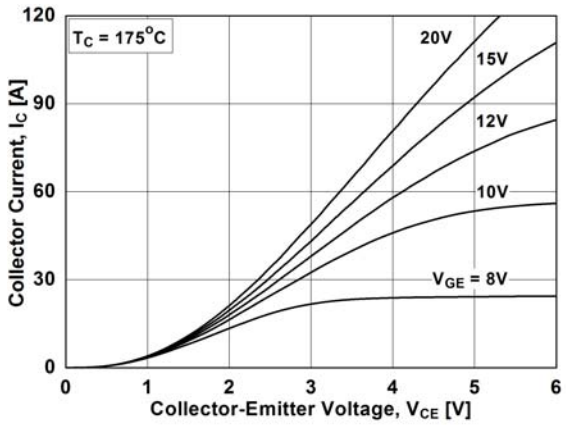


Figure 3. Typical Output Characteristics

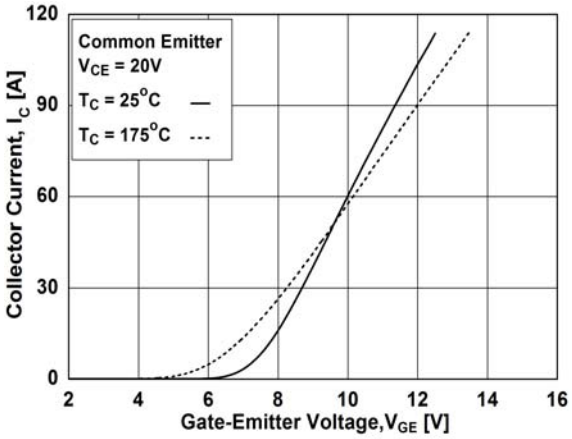


Figure 4. Transfer Characteristic

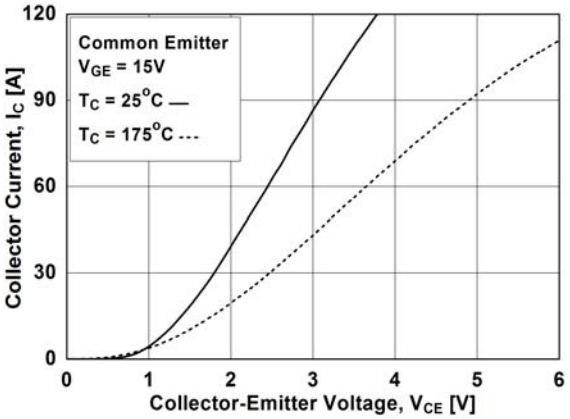


Figure 5. Typical Saturation Voltage

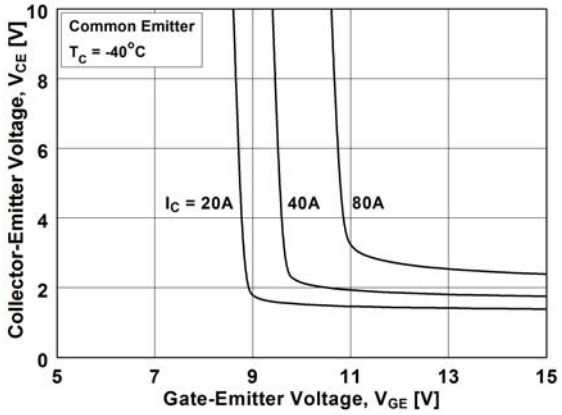


Figure 6. Saturation Voltage vs. V_{GE} Characteristics

Typical Performance Characteristics

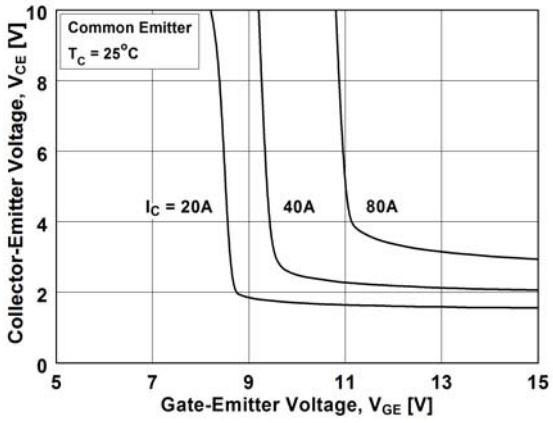


Figure 7. Saturation Voltage vs. V_{GE}

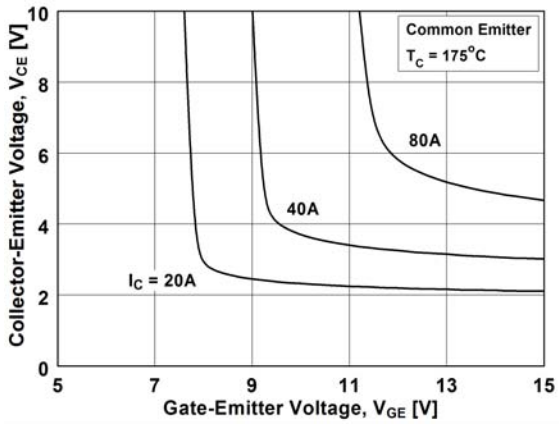


Figure 8. Saturation Voltage vs. V_{GE}

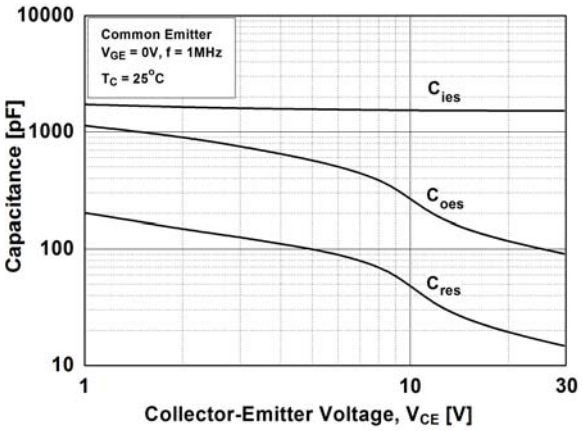


Figure 9. Capacitance Characteristics

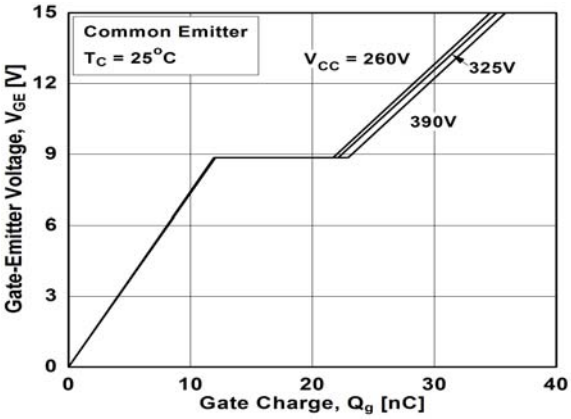


Figure 10. Gate charge Characteristics

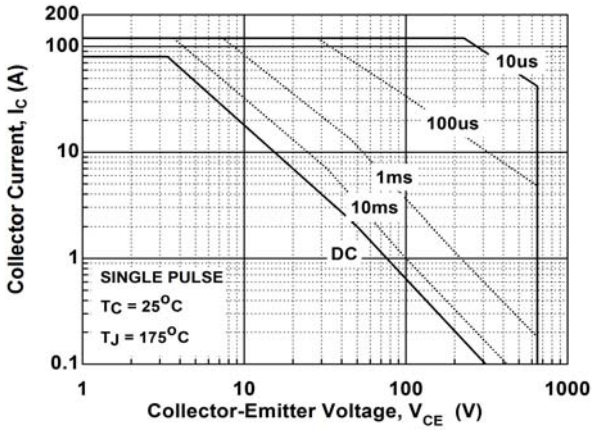


Figure 11. SOA Characteristics

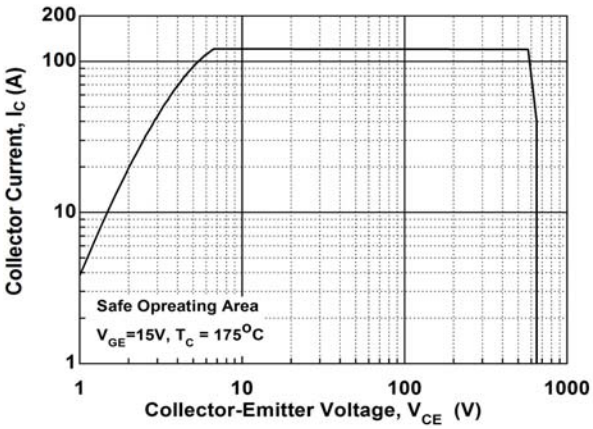


Figure 12. Turn off Switching SOA Characteristics

Typical Performance Characteristics

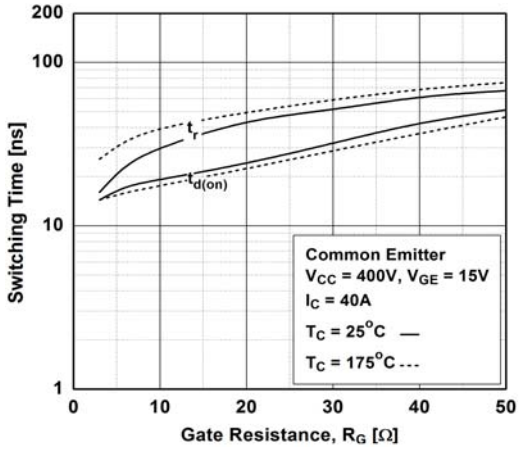


Figure 13. Turn-on Characteristics vs. Gate Resistance

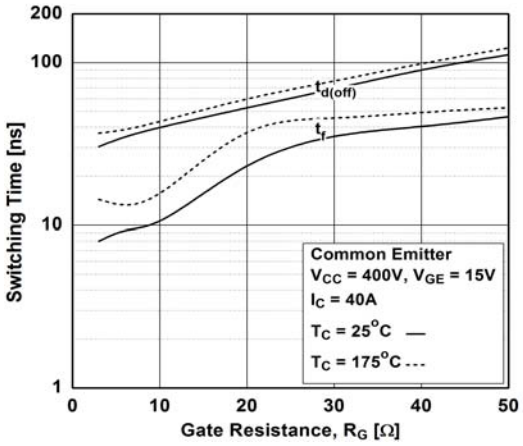


Figure 14. Turn-off Characteristics vs. Gate Resistance

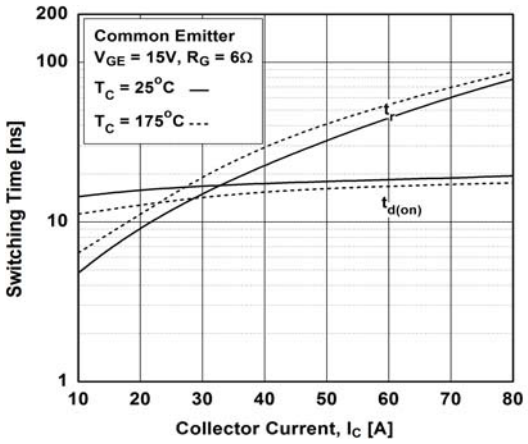


Figure 15. Turn-on Characteristics vs. Collector Current

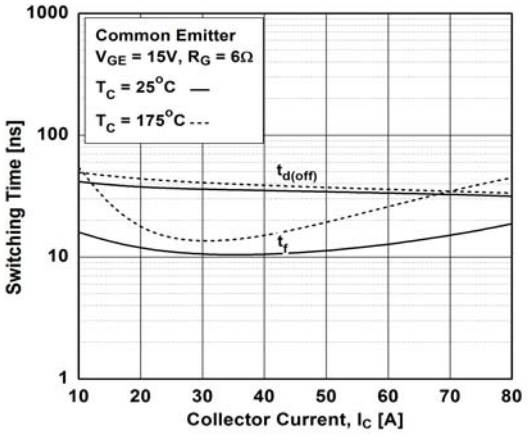


Figure 16. Turn-off Characteristics vs. Collector Current

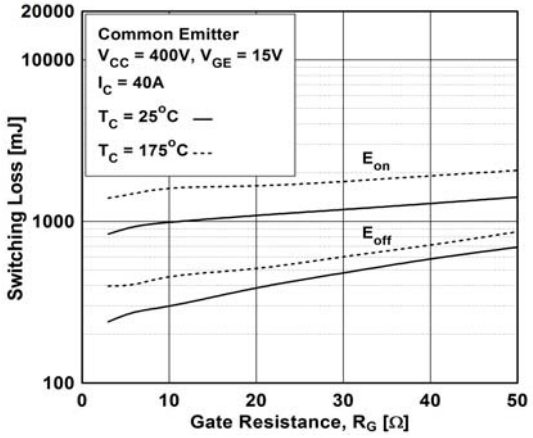


Figure 17. Switching Loss vs Gate Resistance

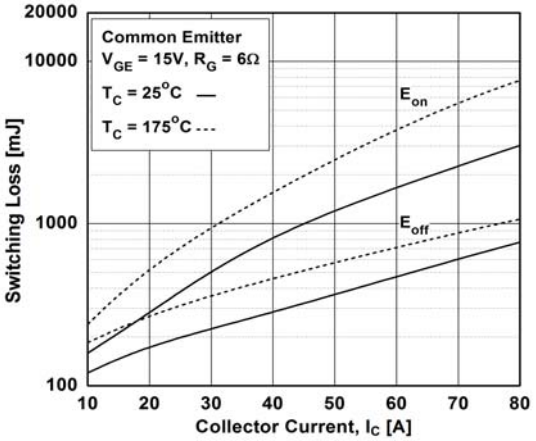


Figure 18. Switching Loss vs Collector Current

Typical Performance Characteristics

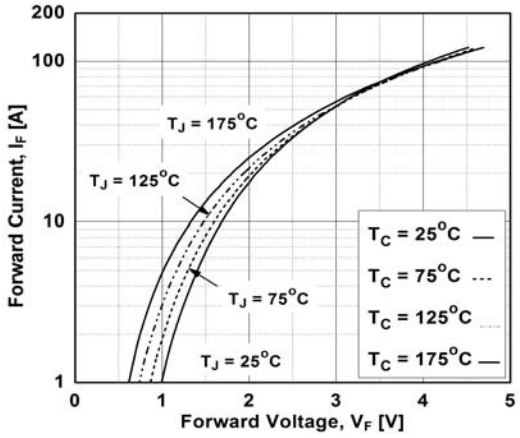


Figure 19. Forward Characteristics

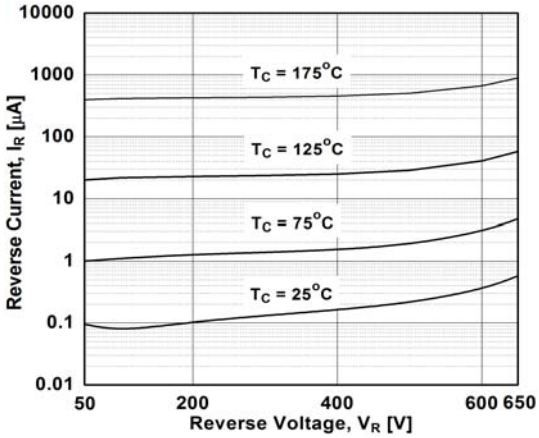


Figure 20. Reverse Current

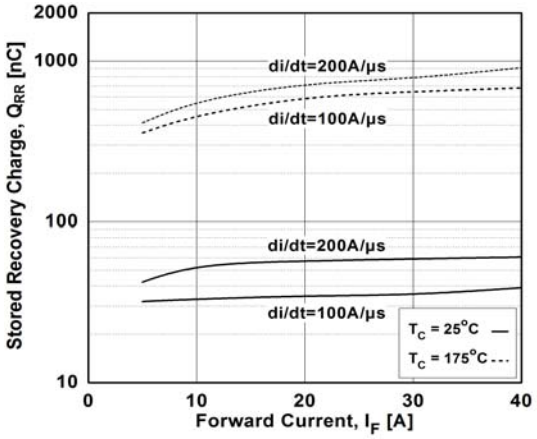


Figure 21. Stored Charge

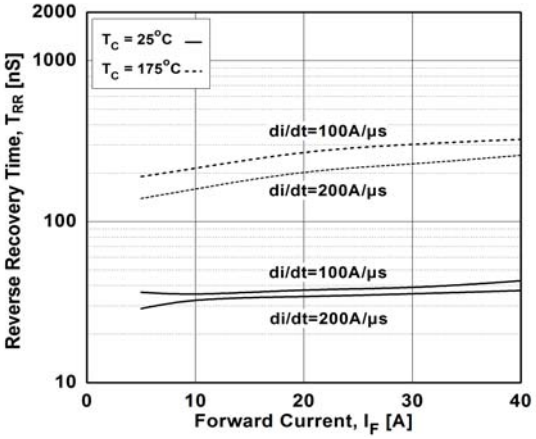


Figure 22. Reverse Recovery Time

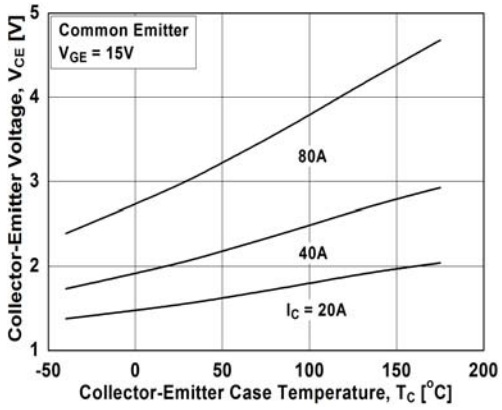


Figure 23. Saturation Voltage vs. Case Temperature at Variant Current Level

Typical Performance Characteristics

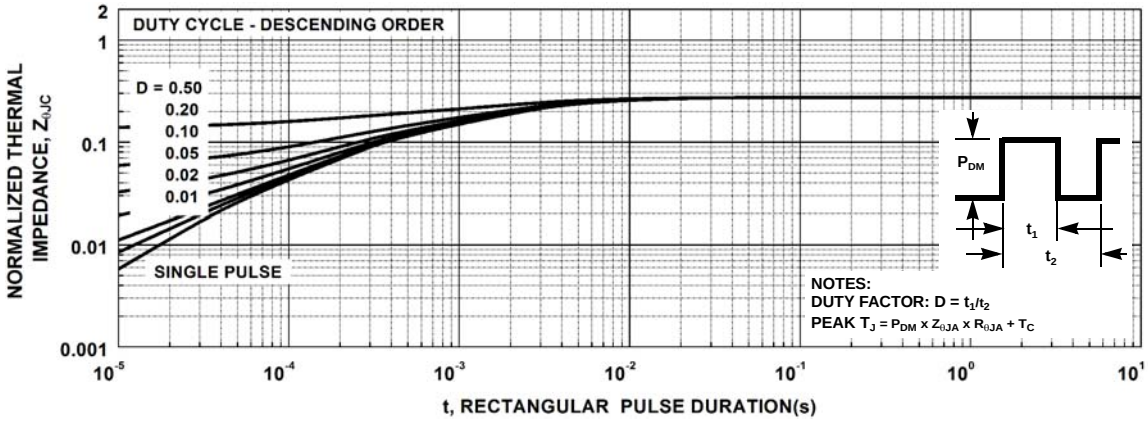


Figure 24. Transient Thermal Impedance of IGBT

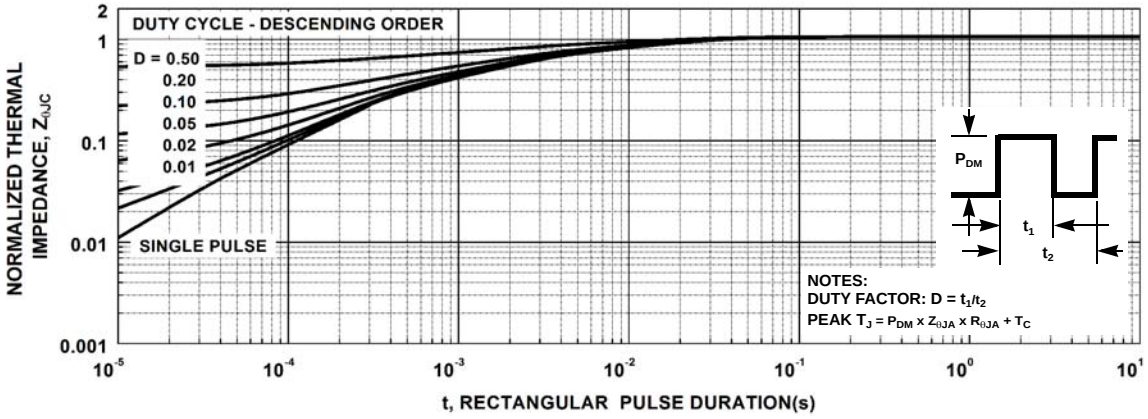


Figure 25. Transient Thermal Impedance of Diode

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